TBP18S030, TBP18SA030 256 BITS (32 WORDS BY 8 BITS) PROGRAMMABLE READ-ONLY MEMORIES

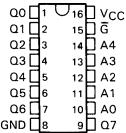
SDMS024 – SEPTEMBER 1979 – REVISED AUGUST 1984

- Titanium-Tungsten (Ti-W) Fuse Link for Reliable Low-Voltage Full Family Compatible Programming
- Full Decoding and Fast Chip Select Simplify System Design
- P-N-P Inputs for Reduced Loading on System Buffers/Drivers
- Applications Include:
 Microprogramming/

Microprogramming/Firmware Loaders Code Converters/Character Generators Translators/Emulators Address Mapping/Look-Up Tables

Choice of 3-State or Open-Collector Outputs

TBP18SA030, TBP18S030 . . . J OR N PACKAGE (TOP VIEW)



description

These monolithic TTL programmable read-only memories (PROMs) feature titanium-tungsten (Ti-W) fuse links with each link designed to program in 20 microseconds. The Schottky-clamped versions of these PROMs offer considerable flexibility for upgrading existing designs or improving new designs as they feature full Schottky clamping for improved performance, low-current MOS-compatible p-n-p inputs, choice of bus-driving three-state or open-collector outputs, and improved chip-select access times.

Data can be electronically programmed, as desired, at any bit location in accordance with the programming procedure specified. All PROMs are supplied with a low-logic level output condition stored at each bit location. The programming procedure open-circuits Ti-W metal links, which reverses the stored logic level at selected locations. The procedure is irreversible; once altered, the output for that bit location is permanently programmed. Outputs that have never been altered may later be programmed to supply the opposite output level. Operation of the unit within the recommended operating conditions will not alter the memory content.

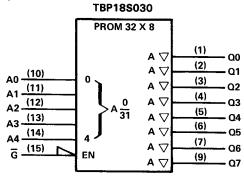
A low level at the chip-select input(s) enables each PROM. The opposite level at any chip-select input causes the outputs to be off.

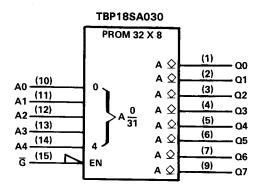
The three-state output offers the convenience of an open-collector with the speed of a totem-pole output; it can be bus-connected to other similar outputs yet it retains the fast rise time characteristic of the TTL totem-pole output. The open-collector output offers the capability of direct interface with a data line having a passive pull up.

A MJ suffix designates full-temperature circuits (formerly 54 Family) and are characterized for operation over the full military temperature range of $-55\,^{\circ}\text{C}$ to $125\,^{\circ}\text{C}$. A J or N suffix designates commercial-temperature circuits (formerly 74 Family) and are characterized for operation from $0\,^{\circ}\text{C}$ to $70\,^{\circ}\text{C}$.

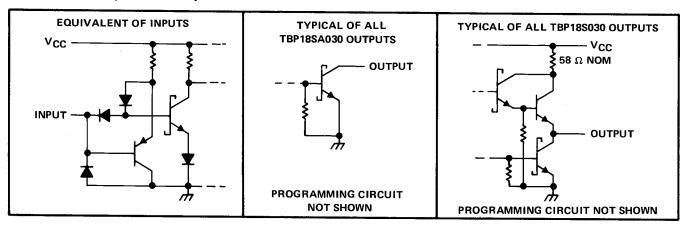
SDMS024 - SEPTEMBER 1979 - REVISED AUGUST 1984

logic symbol





schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage (see Note 1)	
	5.5V
Off-state output voltage	5.5V
Operating free-air temperature range:	Full-temperature-range circuits —55°C to 125°C
	Commercial-temperature-range circuits 0°C to 70°C
Storage temperature range	

recommended conditions for programming TBP18S', TBP18SA PROMs

		MIN	NOM	MAX	UNIT
Supply voltage, VCC (see Note 1)	Steady state	4.75	5	5.25	.,
	Program pulse	9	9.25	9.5	V
Input voltage	High level, VIH	2.4		5	·
mpat voitage	Low level, V _I L	0		0.5	V
Termination of all outputs except the one to be programmed		See load circuit			
Termination of an outputs except the one to be programmed			(Figure 1	-	
Voltage applied to output to be programmed, VO(pr) (see Note 2)		0	0.25	0.3	V
Duration of V _{CC} programming pulse X (see Figure 2 and Note 3)		15	25	100	μs
Programming duty cycle for Y pulse			25	35	%
Free-air temperature		20	25	30	°C

NOTES: 1. Voltage values are with respect to network ground terminal. The supply voltage rating does not apply during programming.

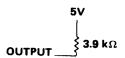
2. The TBP18S030, TBP18SA030 are supplied with all bit locations containing a low logic level, and programming a bit changes the output of the bit to high logic level.



SDMS024 - SEPTEMBER 1979 - REVISED AUGUST 1984

programming procedure

- 1. Apply steady-state supply voltage (V_{CC} = 5 V) and address the word to be programmed.
- 2. Verify that the bit location needs to be programmed. If not, proceed to the next bit.
- 3. If the bit requires programming, disable the outputs by applying a high-logic level voltage to the chip-select input(s).
- 4. Only one bit location is programmed at a time. Connect each output not being programmed to 5 V through 3.9 k Ω and apply the voltage specified in the table to the output to be programmed. Maximum current into the programmer output is 150 mA.
- 5. Step V_{CC} to 9.25 nominal. Maximum supply current required during programming is 750 mA.
- Apply a low-logic-level voltage to the chip-select input(s). This should occur between 1 μs and 1 ms after V_{CC}
 has reached its 9.25 level. See programming sequence of Figure 2.
- 7. After the X pulse time is reached, a high logic level is applied to the chip-select inputs to disable the outputs.
- 8. Within the range of 1 μ s to 1 ms after the chip-select input(s) reach a high logic level, V_{CC} should be stepped down to 5 V at which level verification can be accomplished.
- 9. The chip-select input(s) may be taken to a low logic level (to permit program verification) 1 μ s or more after V_{CC} reaches its steady-state value of 5 V.
- At a Y pulse duty cycle of 35% or less, repeat steps 1 through 8 for each output where it is desired to program a bit.
- Verify accurate programming of every word after all words have been programmed using V_{CC} values of 4.5 and 5.5 volts.



LOAD CIRCUIT FOR EACH OUTPUT NOT BEING PROGRAMMED OR FOR PROGRAM VERIFICATION

FIGURE 1 - LOAD CIRCUIT

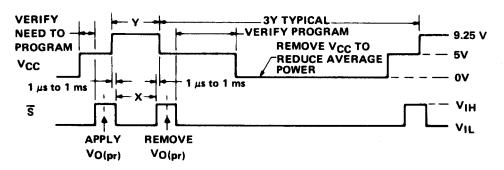


FIGURE 2 - VOLTAGE WAVEFORMS FOR PROGRAMMING



TBP18S030, TBP18SA030 256 BITS (32 WORDS BY 8 BITS) PROGRAMMABLE READ-ONLY MEMORIES

SDMS024 - SEPTEMBER 1979 - REVISED AUGUST 1984

recommended operating conditions (see Note 4)

PARAMETER	T	UNIT			
PARAMETER		MIN	NOM	MAX	DIVIT
C. A. Albana V	MJ	4.5 4.75	5 5	5.5	V
Supply voltage, V _{CC}	J, N			5.25	1 °
	MJ			2	mA
High-level output current, IOH	J,N			-6.5	"
Low-level output current, IOL				20	mA
O	MJ	55		125	°C
Operating free-air temperature, TA	J ,N	0		70	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Note 4)

	PARAMETER	TEST CONDITIONS		FULL TEN (MJ)	1P	C	OMM. TE	MP	UNIT
	TANAMETER	(10) 00/12/110/10	MIN	TYP‡	MAX	MIN	TYP‡	MAX	
VIН	High-level input voltage		2		- 1100	2			V
VIL	Low-level input voltage			-	8.0			0.8	V
VIK	Input clamp voltage	V _{CC} = MIN, I _I = —18 n	ıΑ		-1.2			-1.2	V
Voн	High-level output voltage	V _{CC} = MIN, V _{IH} = 2V, V _{IL} = 0.8V, I _{OH} = MA	x 2.4	3.4		2.4	3.2		V
V _{OL}	Low-level output voltage	V _{CC} = MIN, V _{IH} = 2V, V _{IL} = 0.8V, I _{OL} = MAX	(0.5			0.5	V
lozн	Off-state output current, high-level voltage applied	V _{CC} = MAX, V _{IH} = 2 V, V _O = 2.4 V			50			50	μΑ
lozl	Off-state output current, low-level voltage applied	V _{CC} = MAX, V _{IH} = 2 V, V _O = 0.5 V			—50		1 1 3 1 1 1	50	μΑ
11	Input current at maximum input voltage	V _{CC} = MAX, V _I = 5.5 V			1			1	mA
ΊΗ	High-level input current	V _{CC} = MAX, V _I = 2.7 V			25			25	μΑ
ΙιL	Low-level input current	V _{CC} = MAX, V _I = 0.5 V			-0.25			-0.25	mA
los	Short-circuit output current§	V _{CC} = MAX,	-30		-100	-30		-100	mA
lcc	Supply current	V _{CC} = MAX, Chip select(s) at 0 V, Outputs open, See Note 5		80	110		80	110	mA

switching characteristics over recommended ranges of TA and VCC (unless otherwise noted)

ТҮРЕ	TEST CONDITIONS	ACCE	t _{a(A)} SS TIME ADDRESS		1	t _a (S) S TIME FR T (ENABL	OM CHIP E TIME)		^t dis BLE TIME OR LOW		UNIT
	[MIN	TYP‡	MAX	MIN	TYP [‡]	MAX	MIN	TYP‡	MAX	
TBP18S030MJ	$C_L = 30 \text{ pF for}$ $t_{a(A)} \text{ and } t_{a(S)}$, $5 \text{ pF for } t_{dis}$, See Note 6		25	50		12	30		8	30	ns
TBP18S030			25	40		12	25		8	20	ns

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

^{5.} The typical values of ICC are with all outputs low.



 $^{^{\}ddagger}$ All typical values are at V_{CC} = 5 V, T_A = 25 °C.

[§]Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

NOTES: 4. MJ designates full-temperature circuits (formerly 54 Family), J and N designate commercial-temperature circuits (formerly

SDMS024 - SEPTEMBER 1979 - REVISED AUGUST 1984

recommended operating conditions (see Note 4)

DADAMET	TI					
PARAMET	MIN	NOM	MAX	UNIT		
Summit violations VIII	MJ	4.5	5	5.5	V	
Supply voltage, V _{CC}	J, N	4.75	5	5.25]	
High-level output voltage, VOH				5.5	V	
Low-level output current, IOL				20	mA	
One and the state of the state	MJ	—55		125	00	
Operating free-air temperature, TA	J, N	0		70	- °C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST	CONDITIONS	MIN	TYP [‡]	MAX	UNIT
VIH	High-level input voltage			2			V
V _{IL}	Low-level input voltage					0.8	V
VIK	Input clamp voltage	V _{CC} = MIN,	l _l = —18mA			—1.2	V
ЮН	High-level output current	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V	V _{OH} = 2.4 V V _{OH} = 5.5 V			50 100	μΑ
VOL	Low-level output voltage	V _{CC} = MIN, V _{IL} = 0.8 V,	V _{IH} = 2 V, I _{OL} = MAX			0.5	٧
lı	Input current at maximum input voltage	V _{CC} = MAX,	V ₁ = 5.5 V			1	mA
۱н	High-level input current	V _{CC} = MAX,	V ₁ = 2.7 V			25	μΑ
ηL	Low-level input current	V _{CC} = MAX,	V _I = 0.5 V			-0.25	mA
lcc	Supply current	V _{CC} = MAX, Chip select(s) at 0 See Note 5	V, Outputs open,		80	110	mA

switching characteristics over recommended ranges of TA and VCC (unless otherwise noted)

ТҮРЕ	TEST CONDITIONS	^t (A) ACCESS TIME FROM ADDRESS		^t a(S) ACCESS TIME FROM CHIP SELECT (ENABLE TIME)			tPLH PROPAGATION DELAY TIME, LOW-TO-HIGH-LEVEL OUTPUT FROM CHIP SELECT (DISABLE TIME)			UNIT	
		MIN	TYP‡	MAX	MIN	TYP [‡]	MAX	MIN	TYP‡	MAX	
TBP18SA030MJ	$C_L = 30pF,$ $R_{L1} = 300 \Omega,$		25	50		12	30		12	30	ns
TBP18SA030	$R_{L2} = 600 \Omega$, See Note 6		25	40		12	25		12	25	ns

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

- 5. The typical values of ICC are with all outputs low.
- 6. Load circuits and voltage waveforms are shown in Section 1.



 $^{^{\}ddagger}$ All typical values are at V_{CC} = 5 V, T_A = 25 °C.

NOTES: 4. MJ designates full-temperature circuits (formerly 54 Family), J and N designate commercial-temperature circuits (formerly 74 Family)

www.ti.com 5-May-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
JBP18S030MJ	NRND	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	JBP18S030MJ

⁽¹⁾ Status: For more details on status, see our product life cycle.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025. Texas Instruments Incorporated